



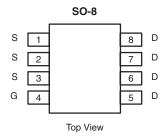
N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
30	0.0090 at V _{GS} = 10 V	16.5	10.5 nC			
30	$0.012 \text{ at V}_{GS} = 4.5 \text{ V}$	13.2	10.5 110			

FEATURES

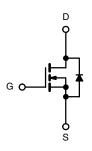
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET[®] Power MOSFETs
- PWM Optimized





Ordering Information: Si4884BDY-T1-E3 (Lead (Pb)-free)

Si4884BDY-T1-GE3 (Lead (Pb)-free and Halogen-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS $T_A = 25 ^{\circ}C$,	unless othe	erwise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20	v	
	T _C = 25 °C		16.5		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	13.2		
Continuous Diam Current (1) = 150 °C)	T _A = 25 °C	- 'D	12.4 ^{b, c}		
	T _A = 70 °C		10.0 ^{b, c}	А .	
Pulsed Drain Current		I _{DM}	50		
Continuous Source-Drain Diode Current	T _C = 25 °C		4.0		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	2.3 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	15		
Avalanche Energy		E _{AS}	11	mJ	
	T _C = 25 °C		4.45		
Maximum Power Dissipation	T _C = 70 °C	P _D	2.85	w	
Maximum rower Dissipation	T _A = 25 °C		2.50 ^{b, c}		
	T _A = 70 °C		1.6 ^{b, c}		
Operating Junction and Storage Temperature	e Range	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	40	50	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	22	28	O/ VV			

Notes

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 85 $^{\circ}\text{C/W}.$

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SPECIFICATIONS T _J = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		30		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = 250 μΑ		6			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Walkana Busin Oamant	1	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	Б	V _{GS} = 10 V, I _D = 10 A		0.007	0.0090		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		0.0095	0.012	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		45		S	
Dynamic ^b					ı		
Input Capacitance	C _{iss}			1525			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		295		pF	
Reverse Transfer Capacitance	C _{rss}			120			
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}$		23.5	35	nC	
Total Gate Charge	otal Gate Charge Q _g			10.5	17		
Gate-Source Charge	Q _{gs}			4.3			
Gate-Drain Charge	Q _{gd}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 12 \text{ A}$		3			
Gate Resistance	Rg	f = 1 MHz		1.4	2.2	Ω	
Turn-on Delay Time	t _{d(on)}			18	30		
Rise Time	t _r	V 45VD 450		160	240		
Turn-Off Delay Time	t _{d(off)}	V_{DD} = 15 V, R _L = 1.5 Ω $I_{D} \cong$ 10 A, V_{GEN} = 4.5 V, R _a = 1 Ω		18	30		
Fall Time	t _f	ID = 10 A, VGEN = 4.5 V, Hg = 1.52		8	15		
Turn-on Delay Time	t _{d(on)}			8	15		
Rise Time	t _r	V 45V B 450		11	18	ns	
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega$		22	35	110	
Fall Time	t _f	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		8	15		
Drain-Source Body Diode Characteristi	cs			l		ı	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			4		
Pulse Diode Forward Current ^a	I _{SM}				50	A	
Body Diode Voltage	V _{SD}	I _S = 2.3 A		0.75	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			25	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 0 5 A 41/41 400 A/vs T 05 00		15	25	nC	
Reverse Recovery Fall Time	t _a	$I_F = 9.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		13			
Reverse Recovery Rise Time	t _b	\dashv		12		ns	

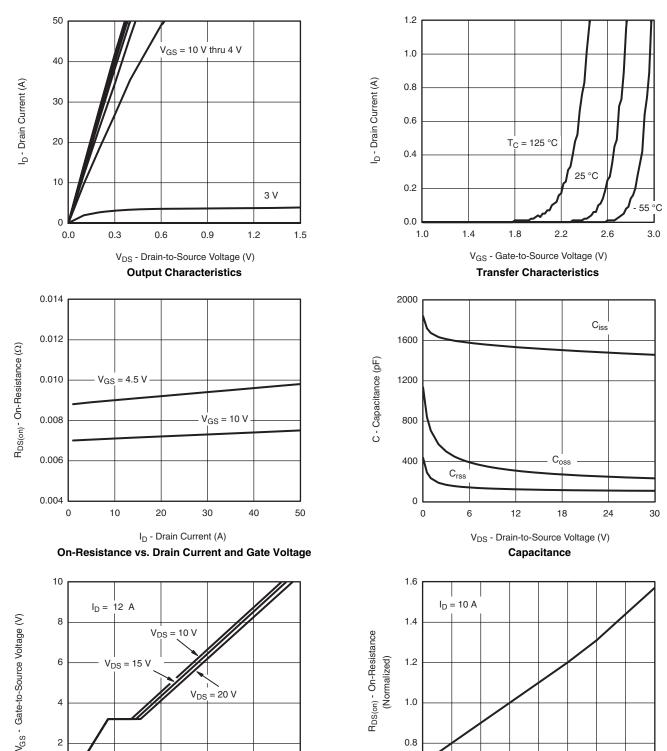
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



0.6

- 50

0

50

T_J - Junction Temperature (°C)

On-Resistance vs. Junction Temperature

75

100

0

10

15

Q_q - Total Gate Charge (nC)

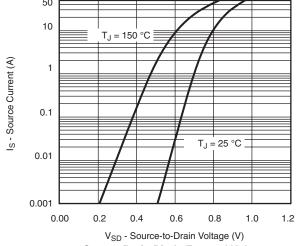
Gate Charge

25

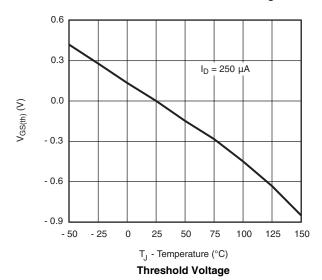
125

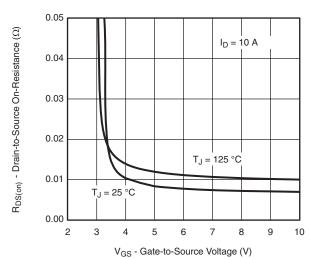
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

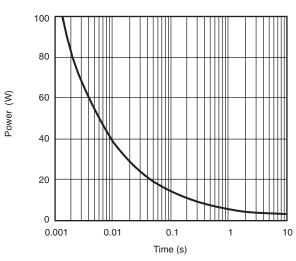




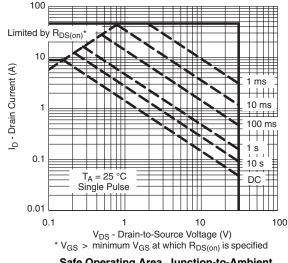




On-Resistance vs. Gate-to-Source Voltage



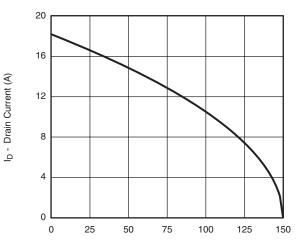
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

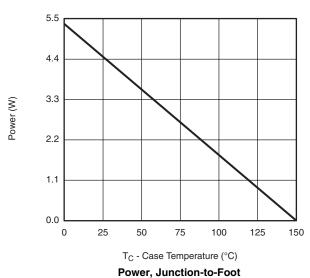


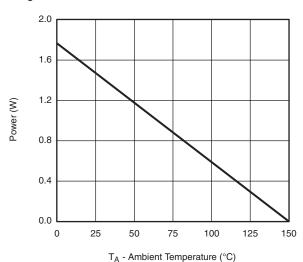
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





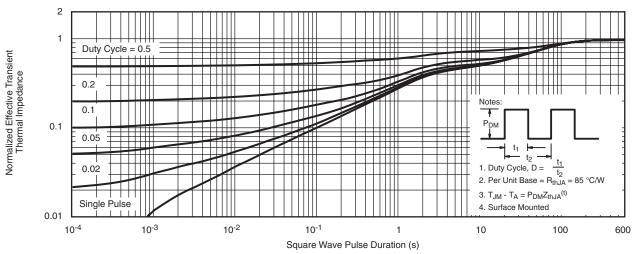
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

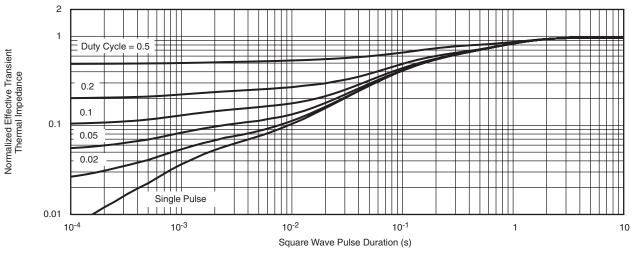
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

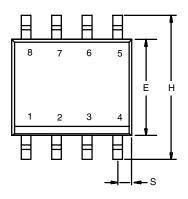


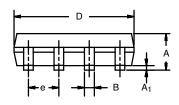
Normalized Thermal Transient Impedance, Junction-to-Case

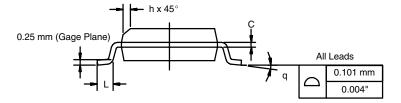
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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INC	INCHES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

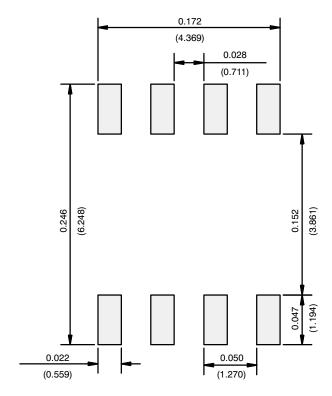
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LON NOTE



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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